

**Search Notes**

Application/Control No.

10/033,088

Examiner

Erin M. File

Applicant(s)/Patent under  
Reexamination

YUICHIRO TAKAMIZAWA

Art Unit

2634

**SEARCHED**

| Class | Subclass | Date     | Examiner |
|-------|----------|----------|----------|
| 358   | 1.15     | 3/2/2005 | EMF      |
| 375   | 240      | 3/2/2005 | EMF      |
| 382   | 239      | 3/2/2005 | EMF      |
| 704   | 201      | 3/2/2005 | EMF      |
| 704   | 500      | 3/2/2005 | EMF      |
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**INTERFERENCE SEARCHED**

| Class | Subclass | Date     | Examiner |
|-------|----------|----------|----------|
| 375   | 240      | 3/2/2005 | EMF      |
| 704   | 500      | 3/2/2005 | EMF      |
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**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

|  | DATE     | EXMR |
|--|----------|------|
| EAST US PAT, USPGPUB, EPO, JPO<br>DERWENT, IBM | 3/2/2005 | EMF  |
| PALM INVENTORSHIP                              | 3/2/2005 | EMF  |
| ACM Digital Library Keyword Search             | 3/2/2005 | EMF  |
| IEEE Explore Keyword Search                    | 3/2/2005 | EMF  |
| GOOGLE Keyword Search                          | 3/2/2005 | EMF  |
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